# DATA SHEET



# SWITCHING N-CHANNEL POWER MOS FET

# DESCRIPTION

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The 2SK3634 is N-channel MOS FET device that features a low on-state resistance and excellent switching characteristics, and designed for high voltage applications such as DC/DC converter.

## FEATURES

- High voltage: VDSS = 200 V
- Gate voltage rating: ±30 V R<sub>DS(on)</sub> = 0.60 Ω MAX. (V<sub>GS</sub> = 10 V, I<sub>D</sub> = 3.0 A)
- Low Ciss: Ciss = 270 pF TYP. (VDs = 10 V, VGs = 0 V)
- Built-in gate protection diode
- TO-251/TO-252 package
- Avalanche capability rated

## ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (VGs = 0 V)	VDSS	200	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±30	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±6.0	А
Drain Current (Pulse) Note1	D(pulse)	±18	А
Total Power Dissipation (Tc = 25°C)	PT1	20	W
Total Power Dissipation ( $T_A = 25^{\circ}C$ )	Рт2	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	las	6.0	Α
Single Avalanche Energy Note2	Eas	3.6	mJ
Repetitive Avalanche Current Note3	AR	6.0	Α
Repetitive Pulse Avalanche Energy Note3	Ear	2.0	mJ

# CRDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3634	TO-251 (MP-3)		
2SK3634-Z	TO-252 (MP-3Z)		

(TO-251)



(TO-252)



#### **Notes 1.** PW $\leq$ 10 $\mu$ s, Duty Cycle $\leq$ 1%

- 2. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 100 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V, L = 100  $\mu$ H
- 3.  $T_{ch} \le 125^{\circ}C$  , RG = 25  $\Omega$ , VDD = 100 V

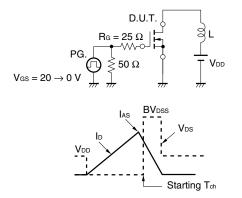
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# ELECTRICAL CHARACTERISTICS (TA = 25°C)

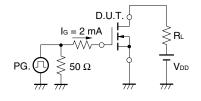
	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	ldss	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V			10	μA
Gate Leakage Current	lgss	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V			±10	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.5	3.5	4.5	V
Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.0 A	2	4		s
Drain to Source On-state Resistance	RDS(on)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.0 A		0.47	0.60	Ω
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		270		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		75		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		33		pF
Turn-on Delay Time	td(on)	V <sub>DD</sub> = 100 V, I <sub>D</sub> = 3.0 A		4		ns
Rise Time	tr	V <sub>GS</sub> = 10 V		8		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 0 Ω		14		ns
Fall Time	tr			6		ns
Total Gate Charge	QG	V <sub>DD</sub> = 160 V		9		nC
Gate to Source Charge	QGS	V <sub>GS</sub> = 10 V		1.5		nC
Gate to Drain Charge	Qgd	I <sub>D</sub> = 6.0 A		4.5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 16 A, V <sub>GS</sub> = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 6 A, V <sub>GS</sub> = 0 V		100		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		320		nC

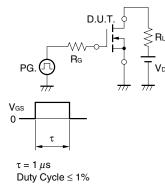
#### TEST CIRCUIT 1 AVALANCHE CAPABILITY

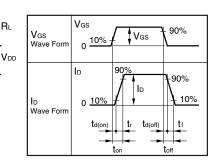
#### **TEST CIRCUIT 2 SWITCHING TIME**



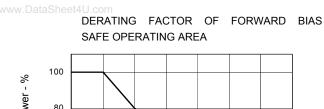
#### TEST CIRCUIT 3 GATE CHARGE

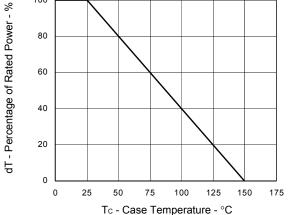




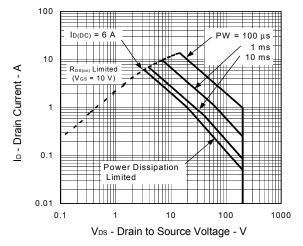


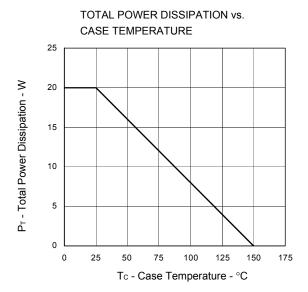
# TYPICAL CHARACTERISTICS ( $T_A = 25^{\circ}C$ )



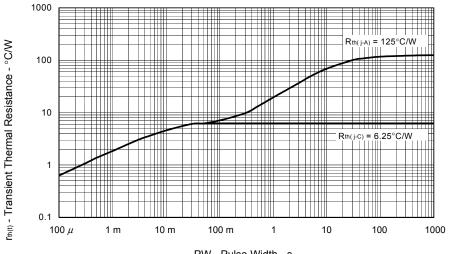


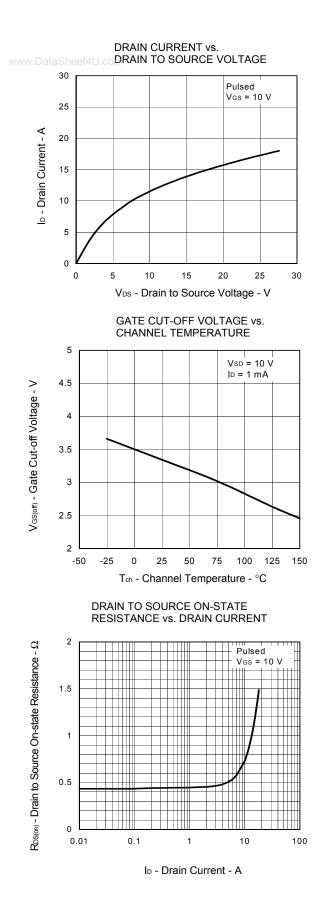






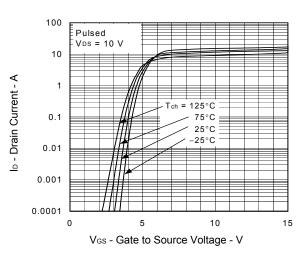
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



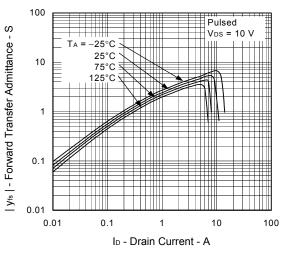


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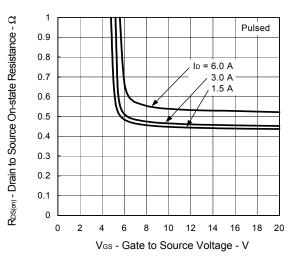
FORWARD TRANSFER CHARACTERISTICS

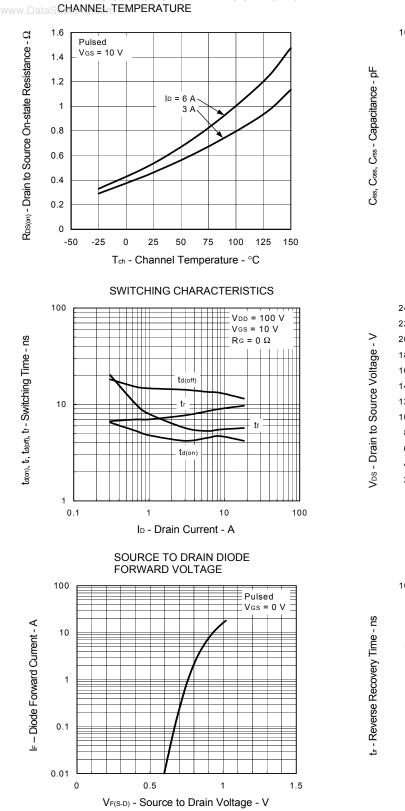


FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



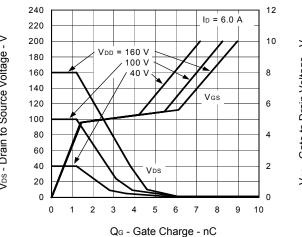


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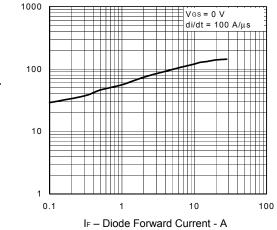
#### DRAIN TO SOURCE ON-STATE RESISTANCE vs. CAPACITANCE vs. CHANNEL TEMPERATURE DRAIN TO SOURCE VOLTAGE

1000 Vgs = 0 V f = 1 MHz Ciss 100 Coss Crss 10 1 0.1 10 100 1000 1 VDS - Drain to Source Voltage - V

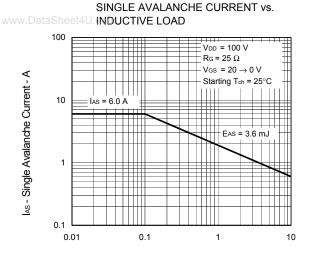
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

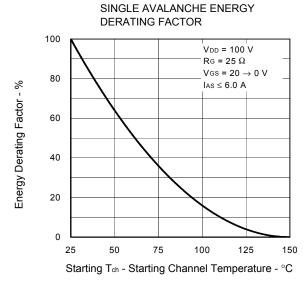


# $V_{GS}$ - Gate to Drain Voltage - V



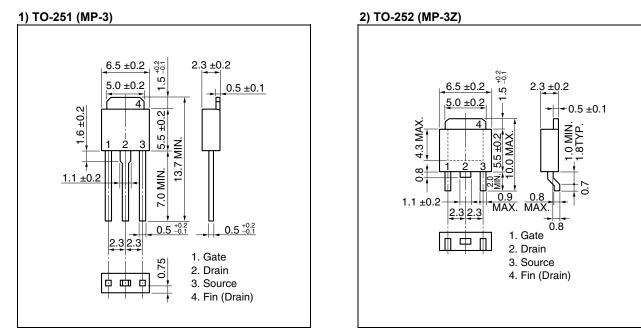
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L - Inductive Load - mH

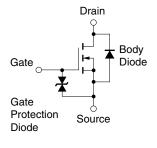


## ★ PACKAGE DRAWINGS (Unit: mm)

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#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device. www.DataSheet4U.com

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